



**THE DATASHEET OF
BQ20Z45DBTR-R1**



SBS 1.1-Compliant Gas Gauge and Protection Enabled With Impedance Track™

Check for Samples: [bq20z45-R1](#)

FEATURES

- **Next Generation Patented Impedance Track™ Technology Accurately Measures Available Charge in Li-Ion and Li-Polymer Batteries**
 - **Better Than 1% Error Over the Lifetime of the Battery**
- **Supports the Smart Battery Specification SBS V1.1**
- **Flexible Configuration for 2 to 4 Series Li-Ion and Li-Polymer Cells**
- **Powerful 8-Bit RISC CPU With Ultralow Power Modes**
- **Full Array of Programmable Protection Features**
 - **Voltage, Current, and Temperature**
- **Satisfies JEITA Guidelines**
- **Added Flexibility to Handle More Complex Charging Profiles**
- **Lifetime Data Logging**
- **Supports SHA-1 Authentication**
- **Complete Battery Protection and Gas Gauge Solution in One Package**
- **Available in a 38-Pin TSSOP (DBT) package**

DESCRIPTION

The bq20z45-R1 SBS-compliant gas gauge and protection IC is a single IC solution designed for battery-pack or in-system installation. The bq20z45-R1 measures and maintains an accurate record of available charge in Li-ion or Li-polymer batteries using its integrated high-performance analog peripherals, monitors capacity change, battery impedance, open-circuit voltage, and other critical parameters of the battery pack as well and reports the information to the system host controller over a serial-communication bus. Together with the integrated analog front-end (AFE) short-circuit and overload protection, the bq20z45-R1 maximizes functionality and safety while minimizing external component count, cost, and size in smart battery circuits.

The implemented Impedance Track™ gas gauging technology continuously analyzes the battery impedance, resulting in superior gas-gauging accuracy. This enables remaining capacity to be calculated with discharge rate, temperature, and cell aging all accounted for during each stage of every cycle with high accuracy.

APPLICATIONS

- **Notebook PCs**
- **Medical and Test Equipment**
- **Portable Instrumentation**

Table 1. AVAILABLE OPTIONS

T _A	PACKAGE ⁽¹⁾	
	38-PIN TSSOP (DBT) Tube	38-PIN TSSOP (DBT) Tape and Reel
–40°C to 85°C	bq20z45-R1DBT ⁽²⁾	bq20z45-R1DBTR ⁽³⁾

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

(2) A single tube quantity is 50 units.

(3) A single reel quantity is 2000 units



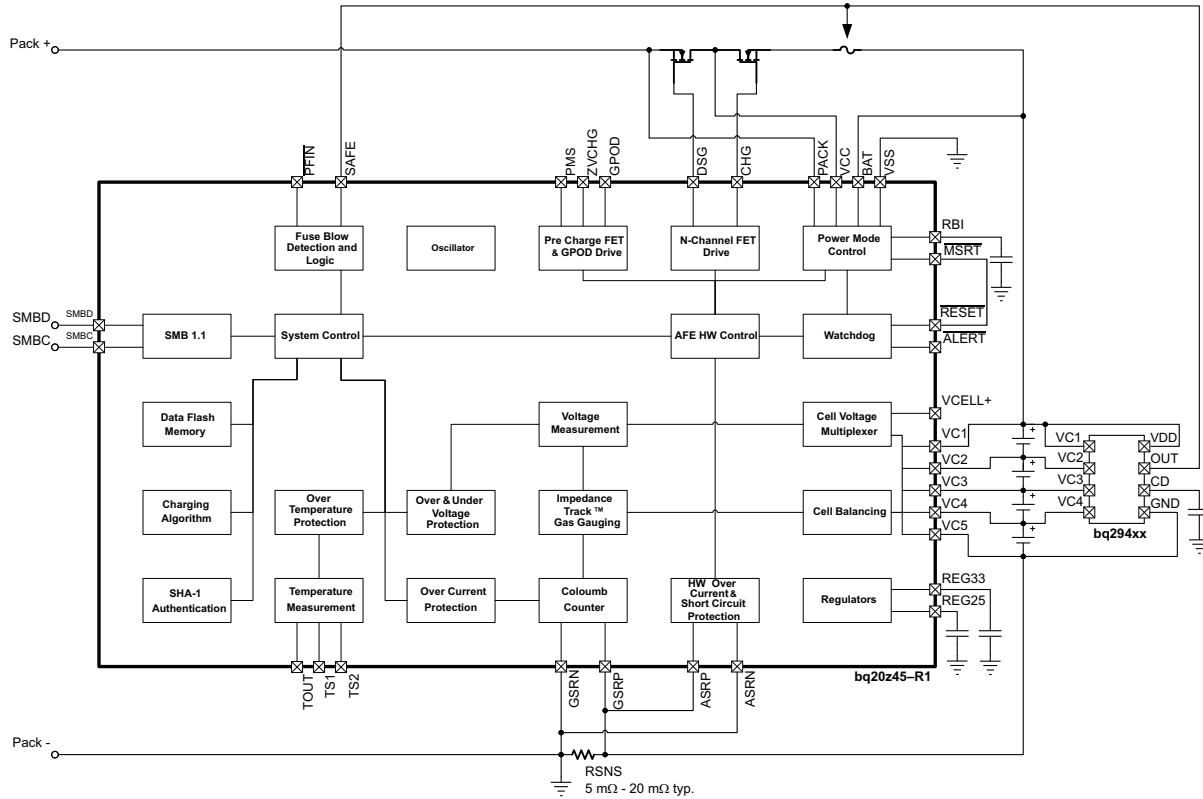
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Impedance Track is a trademark of Texas Instruments.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

SYSTEM PARTITIONING DIAGRAM



**bq20z45-R1
DBT PACKAGE
(TOP VIEW)**

DSG	1	38	CHG
PACK	2	37	BAT
VCC	3	36	VC1
ZVCHG	4	35	VC2
GPOD	5	34	VC3
PMS	6	33	VC4
VSS	7	32	VC5
REG33	8	31	ASRP
TOUT	9	30	ASRN
VCELL+	10	29	RESET
ALERT	11	28	VSS
PRES	12	27	RBI
TS1	13	26	REG25
TS2	14	25	VSS
PFIN	15	24	MRST
SAFE	16	23	GSRN
SMBD	17	22	GSRP
SMBC	18	21	VSS
NC	19	20	VSS

PIN FUNCTIONS

PIN		I/O ⁽¹⁾	DESCRIPTION
NO.	NAME		
1	DSG	O	High side N-chan discharge FET gate drive
2	PACK	IA, P	Battery pack input voltage sense input. It also serves as device wake up when device is in shutdown mode.
3	VCC	P	Positive device supply input. Connect to the center connection of the CHG FET and DSG FET to ensure device supply either from battery stack or battery pack input
4	ZVCHG	O	P-chan pre-charge FET gate drive
5	GPOD	OD	High voltage general purpose open drain output. Can be configured to be used in pre-charge condition
6	PMS	I	Pre-charge mode setting input. Connect to PACK to enable 0v pre-charge using charge FET connected at CHG pin. Connect to VSS to disable 0V pre-charge using charge FET connected at CHG pin.
7	VSS	P	Negative device power supply input. Connect all VSS pins together for operation of device
8	REG33	P	3.3V regulator output. Connect at least a 2.2µF capacitor to REG33 and VSS
9	TOUT	P	Thermistor bias supply output
10	VCELL+	-	Internal cell voltage multiplexer and amplifier output. Connect a 0.1µF capacitor to VCELL+ and VSS
11	$\overline{\text{ALERT}}$	OD	Alert output. In case of short circuit condition, overload condition and watchdog time out this pin will be triggered.
12	$\overline{\text{PRES}}$	I	System / Host present input.
13	TS1	IA	Temperature sensor 1 input
14	TS2	IA	Temperature sensor 2 input
15	$\overline{\text{PFIN}}$	I	Fuse blow detection input
16	SAFE	OD	Blow fuse signal output
17	SMBD	I/OD	SMBus data line
18	SMBC	I/OD	SMBus clock line
19	NC	-	Not connected
20, 21, 25, 28	VSS	P	Negative device power supply input. Connect all VSS pins together for operation of device
22	GSRP	IA	Coulomb counter differential input. Connect to one side of the sense resistor
23	GSRN	IA	Coulomb counter differential input. Connect to one side of the sense resistor
24	$\overline{\text{MRST}}$	I	Reset input for internal CPU core. connect to $\overline{\text{RESET}}$ for correct operation of device
26	REG25	P	2.5V regulator output. Connect at least a 1µF capacitor to REG25 and VSS
27	RBI	P	RAM backup input. Connect a capacitor to this pin and VSS to protect loss of RAM data in case of short circuit condition
29	$\overline{\text{RESET}}$	O	Reset output. Connect to $\overline{\text{MRST}}$.
30	ASRN	IA	Short circuit and overload detection differential input. Connect to sense resistor
31	ASRP	IA	Short circuit and overload detection differential input. Connect to sense resistor
32	VC5	IA, P	Cell voltage sense input and cell balancing input for the negative voltage of the bottom cell in cell stack.
33	VC4	IA, P	Cell voltage sense input and cell balancing input for the positive voltage of the bottom cell and the negative voltage of the second lowest cell in cell stack.
34	VC3	IA, P	Cell voltage sense input and cell balancing input for the positive voltage of the second lowest cell in cell stack and the negative voltage of the second highest cell in 4 cell applications.
35	VC2	IA, P	Cell voltage sense input and cell balancing input for the positive voltage of the second highest cell and the negative voltage of the highest cell in 4 cell applications. Connect to VC3 in 2 cell stack applications
36	VC1	IA, P	Cell voltage sense input and cell balancing input for the positive voltage of the highest cell in cell stack in 4 cell applications. Connect to VC2 in 3 or 2 cell stack applications
37	BAT	I, P	Battery stack voltage sense input
38	CHG	O	High side N-chan charge FET gate drive

(1) I = Input, IA = Analog input, I/O = Input/output, I/OD = Input/Open-drain output, O = Output, OA = Analog output, P = Power

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature (unless otherwise noted) ⁽¹⁾

	PIN	UNIT
V _{SS} Supply voltage range	BAT, VCC	–0.3 V to 34 V
	PACK, PMS	–0.3 V to 34 V
	VC(n)-VC(n+1); n = 1, 2, 3, 4	–0.3 V to 8.5 V
	VC1, VC2, VC3, VC4	–0.3 V to 34 V
	VC5	–0.3 V to 1 V
V _{IN} Input voltage range	$\overline{\text{PFIN}}$, SMBD, SMBC	–0.3 V to 6 V
	TS1, TS2, SAFE, VCELL+, $\overline{\text{PRES}}$, $\overline{\text{ALERT}}$	–0.3 V to V _(REG25) + 0.3 V
	$\overline{\text{MRST}}$, GSRN, GSRP, RBI ASRN, ASRP	–0.3 V to V _(REG25) + 0.3 V –1 V to 1 V
V _{OUT} Output voltage range	DSG, CHG, GPOD	–0.3 V to 34 V
	ZVCHG	–0.3 V to V _(BAT)
	TOUT, $\overline{\text{ALERT}}$, REG33	–0.3 V to 6 V
	$\overline{\text{RESET}}$	–0.3 V to 7 V
	REG25	–0.3 V to 2.75 V
I _{SS} Maximum combined sink current for input pins	$\overline{\text{PRES}}$, $\overline{\text{PFIN}}$, SMBD, SMBC	50 mA
T _A Operating free-air temperature range		–40°C to 85°C
T _F Functional temperature		–40°C to 100°C
T _{stg} Storage temperature range		–65°C to 150°C

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

	PIN	MIN	NOM	MAX	UNIT
V _{SS} Supply voltage	VCC, BAT	4.5		25	V
V _(STARTUP) Minimum startup voltage	VCC, BAT, PACK	5.5			V
V _{IN} Input Voltage Range	VC(n)-VC(n+1); n = 1,2,3,4	0		5	V
	VC1, VC2, VC3, VC4	0		V _{SS}	V
	VC5	0		0.5	V
	ASRN, ASRP	–0.5		0.5	V
	PACK, PMS	0		25	V
V _(GPOD) Output Voltage Range	GPOD	0		25	V
I _(GPOD) Drain Current ⁽¹⁾	GPOD			1	mA
C _(REG25) 2.5V LDO Capacitor	REG25	1			μF
C _(REG33) 3.3V LDO Capacitor	REG33	2.2			μF
C _(VCELL+) Cell Voltage Output Capacitor	VCELL+	0.1			μF
R _(PACK) PACK input block resistor ⁽²⁾	PACK	1			kΩ

- (1) Use an external resistor to limit the current to GPOD to 1mA in high voltage application.
 (2) Use an external resistor to limit the inrush current PACK pin required.

ELECTRICAL CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted), $T_A = -40^{\circ}\text{C}$ to 85°C , $V_{(\text{REG25})} = 2.41\text{ V}$ to 2.59 V , $V_{(\text{BAT})} = 14\text{ V}$, $C_{(\text{REG25})} = 1\text{ }\mu\text{F}$, $C_{(\text{REG33})} = 2.2\text{ }\mu\text{F}$; typical values at $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
SUPPLY CURRENT						
$I_{(\text{NORMAL})}$	Firmware running		550		μA	
$I_{(\text{SLEEP})}$	Sleep Mode	CHG FET on; DSG FET on		124	μA	
		CHG FET off; DSG FET on		90	μA	
		CHG FET off; DSG FET off		52	μA	
$I_{(\text{SHUTDOWN})}$	Shutdown Mode		0.1	1	μA	
SHUTDOWN WAKE; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$I_{(\text{PACK})}$	Shutdown exit at V_{STARTUP} threshold			1	μA	
SRx WAKE FROM SLEEP; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$V_{(\text{WAKE})}$	Positive or negative wake threshold with 1.00 mV, 2.25 mV, 4.5 mV and 9 mV programmable options		1.25	10	mV	
$V_{(\text{WAKE_ACR})}$	Accuracy of $V_{(\text{WAKE})}$	$V_{(\text{WAKE})} = 1\text{ mV}$; $I_{(\text{WAKE})} = 0$, $\text{RSNS1} = 0$, $\text{RSNS0} = 1$;	-0.7	0.7	mV	
		$V_{(\text{WAKE})} = 2.25\text{ mV}$; $I_{(\text{WAKE})} = 1$, $\text{RSNS1} = 0$, $\text{RSNS0} = 1$; $I_{(\text{WAKE})} = 0$, $\text{RSNS1} = 1$, $\text{RSNS0} = 0$;	-0.8	0.8		
		$V_{(\text{WAKE})} = 4.5\text{ mV}$; $I_{(\text{WAKE})} = 1$, $\text{RSNS1} = 1$, $\text{RSNS0} = 1$; $I_{(\text{WAKE})} = 0$, $\text{RSNS1} = 1$, $\text{RSNS0} = 0$;	-1.0	1.0		
		$V_{(\text{WAKE})} = 9\text{ mV}$; $I_{(\text{WAKE})} = 1$, $\text{RSNS1} = 1$, $\text{RSNS0} = 1$;	-1.4	1.4		
$V_{(\text{WAKE_TCO})}$	Temperature drift of $V_{(\text{WAKE})}$ accuracy		0.5		$\%/^{\circ}\text{C}$	
$t_{(\text{WAKE})}$	Time from application of current and wake of bq20z45-R1		1	10	ms	
POWER-ON RESET						
$V_{\text{IT-}}$	Negative-going voltage input	Voltage at REG25 pin	1.70	1.80	1.90	V
V_{hys}	Hysteresis	$V_{\text{IT+}} - V_{\text{IT-}}$	50	150	250	mV
t_{RST}	$\overline{\text{RESET}}$ active low time	active low time after power up or watchdog reset	100	250	560	μs
WATCHDOG TIMER						
t_{WDTINT}	Watchdog start up detect time		250	500	1000	ms
t_{WDWT}	Watchdog detect time		50	100	150	μs
2.5V LDO; $I_{(\text{REG33OUT})} = 0\text{ mA}$; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$V_{(\text{REG25})}$	Regulator output voltage	$4.5 < \text{VCC}$ or $\text{BAT} < 25\text{ V}$; $I_{(\text{REG25OUT})} \leq 16\text{ mA}$; $T_A = -40^{\circ}\text{C}$ to 100°C	2.41	2.5	2.59	V
$\Delta V_{(\text{REG25TEMP})}$	Regulator output change with temperature	$I_{(\text{REG25OUT})} = 2\text{ mA}$; $T_A = -40^{\circ}\text{C}$ to 100°C		± 0.2		%
$\Delta V_{(\text{REG25LINE})}$	Line regulation	$5.4 < \text{VCC}$ or $\text{BAT} < 25\text{ V}$; $I_{(\text{REG25OUT})} = 2\text{ mA}$		3	10	mV
$\Delta V_{(\text{REG25LOAD})}$	Load Regulation	$0.2\text{ mA} \leq I_{(\text{REG25OUT})} \leq 2\text{ mA}$		7	25	mV
		$0.2\text{ mA} \leq I_{(\text{REG25OUT})} \leq 16\text{ mA}$		25	50	
$I_{(\text{REG25MAX})}$	Current Limit	drawing current until $\text{REG25} = 2\text{ V}$ to 0 V	5	40	75	mA
3.3V LDO; $I_{(\text{REG25OUT})} = 0\text{ mA}$; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$V_{(\text{REG33})}$	Regulator output voltage	$4.5 < \text{VCC}$ or $\text{BAT} < 25\text{ V}$; $I_{(\text{REG33OUT})} \leq 25\text{ mA}$; $T_A = -40^{\circ}\text{C}$ to 100°C	3	3.3	3.6	V
$\Delta V_{(\text{REG33TEMP})}$	Regulator output change with temperature	$I_{(\text{REG33OUT})} = 2\text{ mA}$; $T_A = -40^{\circ}\text{C}$ to 100°C		± 0.2		%
$\Delta V_{(\text{REG33LINE})}$	Line regulation	$5.4 < \text{VCC}$ or $\text{BAT} < 25\text{ V}$; $I_{(\text{REG33OUT})} = 2\text{ mA}$		3	10	mV

ELECTRICAL CHARACTERISTICS (continued)

over operating free-air temperature range (unless otherwise noted), $T_A = -40^{\circ}\text{C}$ to 85°C , $V_{(\text{REG25})} = 2.41\text{ V}$ to 2.59 V , $V_{(\text{BAT})} = 14\text{ V}$, $C_{(\text{REG25})} = 1\text{ }\mu\text{F}$, $C_{(\text{REG33})} = 2.2\text{ }\mu\text{F}$; typical values at $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$\Delta V_{(\text{REG33LOAD})}$	Load Regulation	$0.2\text{ mA} \leq I_{(\text{REG33OUT})} \leq 2\text{ mA}$		7	17	mV
		$0.2\text{ mA} \leq I_{(\text{REG33OUT})} \leq 25\text{ mA}$		40	100	
$I_{(\text{REG33MAX})}$	Current Limit	drawing current until REG33 = 3 V	25	100	145	mA
		short REG33 to VSS, REG33 = 0 V	12		65	
THERMISTOR DRIVE						
$V_{(\text{TOUT})}$	Output voltage	$I_{(\text{TOUT})} = 0\text{ mA}$; $T_A = 25^{\circ}\text{C}$		$V_{(\text{REG25})}$		V
$R_{\text{DS(on)}}$	TOUT pass element resistance	$I_{(\text{TOUT})} = 1\text{ mA}$; $R_{\text{DS(on)}} = (V_{(\text{REG25})} - V_{(\text{TOUT})}) / 1\text{ mA}$; $T_A = -40^{\circ}\text{C}$ to 100°C		50	100	Ω
VCELL+ HIGH VOLTAGE TRANSLATION						
$V_{(\text{VCELL+OUT})}$		$VC(n) - VC(n+1) = 0\text{ V}$; $T_A = -40^{\circ}\text{C}$ to 100°C	0.950	0.975	1	V
		$VC(n) - VC(n+1) = 4.5\text{ V}$; $T_A = -40^{\circ}\text{C}$ to 100°C	0.275	0.3	0.375	
$V_{(\text{VCELL+REF})}$	Translation output	internal AFE reference voltage ; $T_A = -40^{\circ}\text{C}$ to 100°C	0.965	0.975	0.985	V
$V_{(\text{VCELL+PACK})}$		Voltage at PACK pin; $T_A = -40^{\circ}\text{C}$ to 100°C	$0.98 \times V_{(\text{PACK})}/18$	$V_{(\text{PACK})}/18$	$1.02 \times V_{(\text{PACK})}/18$	
$V_{(\text{VCELL+BAT})}$		Voltage at BAT pin; $T_A = -40^{\circ}\text{C}$ to 100°C	$0.98 \times V_{(\text{BAT})}/18$	$V_{(\text{BAT})}/18$	$1.02 \times V_{(\text{BAT})}/18$	
CMMR	Common mode rejection ratio	VCELL+	40			dB
K	Cell scale factor	$K = \{V_{\text{CELL+ output}}(VC5=0V; VC4=4.5V) - V_{\text{CELL+ output}}(VC5=0V; VC4=0V)\}/4.5$	0.147	0.150	0.153	
		$K = \{V_{\text{CELL+ output}}(VC2=13.5V; VC1=18V) - V_{\text{CELL+ output}}(VC5=13.5V; VC1=13.5V)\}/4.5$	0.147	0.150	0.153	
$I_{(\text{VCELL+OUT})}$	Drive Current to VCELL+ capacitor	$VC(n) - VC(n+1) = 0V$; $V_{\text{CELL+}} = 0\text{ V}$; $T_A = -40^{\circ}\text{C}$ to 100°C	12	18		μA
$V_{(\text{VCELL+O})}$	CELL offset error	CELL output ($VC2 = VC1 = 18\text{ V}$) - CELL output ($VC2 = VC1 = 0\text{ V}$)	-18	-1	18	mV
I_{VChL}	VC(n) pin leakage current	VC1, VC2, VC3, VC4, VC5 = 3 V	-1	0.01	1	μA
CELL BALANCING						
$R_{(\text{BAL})}$	internal cell balancing FET resistance	$R_{\text{DS(on)}}$ for internal FET switch at $V_{\text{DS}} = 2\text{ V}$; $T_A = 25^{\circ}\text{C}$	200	400	600	Ω
HARDWARE SHORT CIRCUIT AND OVERLOAD PROTECTION; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$V_{(\text{OL})}$	OL detection threshold voltage accuracy	$V_{\text{OL}} = 25\text{ mV}$ (min)	15	25	35	mV
		$V_{\text{OL}} = 100\text{ mV}$; $RSNS = 0, 1$	90	100	110	
		$V_{\text{OL}} = 205\text{ mV}$ (max)	185	205	225	
$V_{(\text{SCC})}$	SCC detection threshold voltage accuracy	$V_{(\text{SCC})} = 50\text{ mV}$ (min)	30	50	70	mV
		$V_{(\text{SCC})} = 200\text{ mV}$; $RSNS = 0, 1$	180	200	220	
		$V_{(\text{SCC})} = 475\text{ mV}$ (max)	428	475	523	
$V_{(\text{SCD})}$	SCD detection threshold voltage accuracy	$V_{(\text{SCD})} = -50\text{ mV}$ (min)	-30	-50	-70	mV
		$V_{(\text{SCD})} = -200\text{ mV}$; $RSNS = 0, 1$	-180	-200	-220	
		$V_{(\text{SCD})} = -475\text{ mV}$ (max)	-428	-475	-523	
t_{da}	Delay time accuracy		± 15.25			μs
t_{pd}	Protection circuit propagation delay		50			μs
FET DRIVE CIRCUIT; $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)						
$V_{(\text{DSGON})}$	DSG pin output on voltage	$V_{(\text{DSGON})} = V_{(\text{DSG})} - V_{(\text{PACK})}$; $V_{(\text{GS})}$ connect to $10\text{ M}\Omega$; DSG and CHG on; $T_A = -40^{\circ}\text{C}$ to 100°C	8	12	16	V
$V_{(\text{CHGON})}$	CHG pin output on voltage	$V_{(\text{CHGON})} = V_{(\text{CHG})} - V_{(\text{BAT})}$; $V_{(\text{GS})} = 10\text{ M}\Omega$; DSG and CHG on; $T_A = -40^{\circ}\text{C}$ to 100°C	8	12	16	V
$V_{(\text{DSGOFF})}$	DSG pin output off voltage	$V_{(\text{DSGOFF})} = V_{(\text{DSG})} - V_{(\text{PACK})}$			0.2	V
$V_{(\text{CHGOFF})}$	CHG pin output off voltage	$V_{(\text{CHGOFF})} = V_{(\text{CHG})} - V_{(\text{BAT})}$			0.2	V

ELECTRICAL CHARACTERISTICS (continued)

 over operating free-air temperature range (unless otherwise noted), $T_A = -40^{\circ}\text{C}$ to 85°C , $V_{(\text{REG25})} = 2.41\text{ V}$ to 2.59 V , $V_{(\text{BAT})} = 14\text{ V}$, $C_{(\text{REG25})} = 1\text{ }\mu\text{F}$, $C_{(\text{REG33})} = 2.2\text{ }\mu\text{F}$; typical values at $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
t_r	Rise time	$C_L = 4700\text{ pF}$	V(CHG): $V_{(\text{PACK})} \geq V_{(\text{PACK})} + 4\text{ V}$		400	1000	μs
			V(DSG): $V_{(\text{BAT})} \geq V_{(\text{BAT})} + 4\text{ V}$		400	1000	
t_f	Fall time	$C_L = 4700\text{ pF}$	V(CHG): $V_{(\text{PACK})} + V_{(\text{CHGON})} \geq V_{(\text{PACK})} + 1\text{ V}$		40	200	μs
			V(DSG): $\text{VC1} + V_{(\text{DSGON})} \geq \text{VC1} + 1\text{ V}$		40	200	
$V_{(\text{ZVCHG})}$	ZVCHG clamp voltage	BAT = 4.5 V	3.3	3.5	3.7	V	
LOGIC; $T_A = -40^{\circ}\text{C}$ to 100°C (unless otherwise noted)							
$R_{(\text{PULLUP})}$	Internal pullup resistance	$\overline{\text{ALERT}}$	60	100	200	k Ω	
		$\overline{\text{RESET}}$	1	3	6		
V_{OL}	Logic low output voltage level	$\overline{\text{ALERT}}$			0.2	V	
		$\overline{\text{RESET}}$; $V_{(\text{BAT})} = 7\text{ V}$; $V_{(\text{REG25})} = 1.5\text{ V}$; $I_{(\overline{\text{RESET}})} = 200\text{ }\mu\text{A}$			0.4		
		GPOD; $I_{(\text{GPOD})} = 50\text{ }\mu\text{A}$			0.6		
LOGIC SMBC, SMBD, $\overline{\text{PFIN}}$, $\overline{\text{PRES}}$, SAFE, ALERT							
V_{IH}	High-level input voltage		2.0			V	
V_{IL}	Low-level input voltage				0.8	V	
V_{OH}	Output voltage high ⁽¹⁾	$I_L = -0.5\text{ mA}$	$V_{\text{REG25}} - 0.5$			V	
V_{OL}	Low-level output voltage	$\overline{\text{PRES}}$, $\overline{\text{PFIN}}$, $\overline{\text{ALERT}}$, $I_L = 7\text{ mA}$;			0.4	V	
C_i	Input capacitance			5		pF	
$I_{(\text{SAFE})}$	SAFE source currents	SAFE active, $\text{SAFE} = V_{(\text{REG25})} - 0.6\text{ V}$	-3			mA	
I_{ikg}	SAFE leakage current	SAFE inactive	-0.2		0.2	μA	
	Input leakage current				1	μA	
ADC⁽²⁾							
	Input voltage range	TS1, TS2, using Internal V_{ref}	-0.2		1	V	
	Conversion time			31.5		ms	
	Resolution (no missing codes)		16			bits	
	Effective resolution		14	15		bits	
	Integral nonlinearity				± 0.03	%FSR ⁽³⁾	
	Offset error ⁽⁴⁾			140	250	μV	
	Offset error drift ⁽⁴⁾	$T_A = 25^{\circ}\text{C}$ to 85°C		2.5	18	$\mu\text{V}/^{\circ}\text{C}$	
	Full-scale error ⁽⁵⁾			$\pm 0.1\%$	$\pm 0.7\%$		
	Full-scale error drift			50		PPM/ $^{\circ}\text{C}$	
	Effective input resistance ⁽⁶⁾		8			M Ω	
COULOMB COUNTER							
	Input voltage range		-0.20		0.20	V	
	Conversion time	Single conversion		250		ms	
	Effective resolution	Single conversion	15			bits	
	Integral nonlinearity	-0.1 V to 0.20 V	± 0.007		± 0.034	%FSR	
		-0.20 V to -0.1 V	± 0.007				
	Offset error ⁽⁷⁾	$T_A = 25^{\circ}\text{C}$ to 85°C		10		μV	
	Offset error drift			0.4	0.7	$\mu\text{V}/^{\circ}\text{C}$	
	Full-scale error ⁽⁸⁾ ⁽⁹⁾			$\pm 0.35\%$			
	Full-scale error drift			150		PPM/ $^{\circ}\text{C}$	

(1) RC[0:7] bus

(2) Unless otherwise specified, the specification limits are valid at all measurement speed modes

(3) Full-scale reference

(4) Post-calibration performance and no I/O changes during conversion with SRN as the ground reference

(5) Uncalibrated performance. This gain error can be eliminated with external calibration.

(6) The A/D input is a switched-capacitor input. Since the input is switched, the effective input resistance is a measure of the average resistance.

(7) Post-calibration performance

 (8) Reference voltage for the coulomb counter is typically $V_{\text{ref}}/3.969$ at $V_{(\text{REG25})} = 2.5\text{ V}$, $T_A = 25^{\circ}\text{C}$.

(9) Uncalibrated performance. This gain error can be eliminated with external calibration.

ELECTRICAL CHARACTERISTICS (continued)

over operating free-air temperature range (unless otherwise noted), $T_A = -40^{\circ}\text{C}$ to 85°C , $V_{(\text{REG25})} = 2.41\text{ V}$ to 2.59 V , $V_{(\text{BAT})} = 14\text{ V}$, $C_{(\text{REG25})} = 1\text{ }\mu\text{F}$, $C_{(\text{REG33})} = 2.2\text{ }\mu\text{F}$; typical values at $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Effective input resistance ⁽¹⁰⁾	$T_A = 25^{\circ}\text{C}$ to 85°C	2.5			$\text{M}\Omega$
INTERNAL TEMPERATURE SENSOR					
$V_{(\text{TEMP})}$ Temperature sensor voltage ⁽¹¹⁾			-2.0		$\text{mV}/^{\circ}\text{C}$
VOLTAGE REFERENCE					
Output voltage		1.215	1.225	1.230	V
Output voltage drift			65		$\text{PPM}/^{\circ}\text{C}$
HIGH FREQUENCY OSCILLATOR					
$f_{(\text{OSC})}$ Operating frequency			4.194		MHz
$f_{(\text{EIO})}$ Frequency error ^{(12) (13)}		-3%	0.25%	3%	
	$T_A = 20^{\circ}\text{C}$ to 70°C	-2%	0.25%	2%	
$t_{(\text{SXO})}$ Start-up time ⁽¹⁴⁾			2.5	5	ms
LOW FREQUENCY OSCILLATOR					
$f_{(\text{LOSC})}$ Operating frequency			32.768		kHz
$f_{(\text{LEIO})}$ Frequency error ^{(13) (15)}		-2.5%	0.25%	2.5%	
	$T_A = 20^{\circ}\text{C}$ to 70°C	-1.5%	0.25%	1.5%	
$t_{(\text{LSXO})}$ Start-up time ⁽¹⁴⁾				500	μs

(10) The CC input is a switched capacitor input. Since the input is switched, the effective input resistance is a measure of the average resistance.

(11) $-53.7\text{ LSB}/^{\circ}\text{C}$

(12) The frequency error is measured from 4.194 MHz.

(13) The frequency drift is included and measured from the trimmed frequency at $V_{(\text{REG25})} = 2.5\text{ V}$, $T_A = 25^{\circ}\text{C}$

(14) The startup time is defined as the time it takes for the oscillator output frequency to be $\pm 3\%$

(15) The frequency error is measured from 32.768 kHz.

DATA FLASH CHARACTERISTICS OVER RECOMMENDED OPERATING TEMPERATURE AND SUPPLY VOLTAGE

 Typical Values at $T_A = 25^\circ\text{C}$ and $V_{(\text{REG25})} = 2.5\text{ V}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Data retention	See ⁽¹⁾	10			Years
Flash programming write-cycles		20k			Cycles
$t_{(\text{ROWPROG})}$ Row programming time				2	ms
$t_{(\text{MASSERASE})}$ Mass-erase time				200	ms
$t_{(\text{PAGEERASE})}$ Page-erase time				20	ms
$I_{(\text{DDPROG})}$ Flash-write supply current				5	10
$I_{(\text{DDERASE})}$ Flash-erase supply current			5	10	mA
RAM BACKUP					
$I_{(\text{RB})}$ RB data-retention input current	$V_{(\text{RBI})} > V_{(\text{RBI})\text{MIN}}$, $V_{\text{REG25}} < V_{\text{IT-}}$, $T_A = 85^\circ\text{C}$		1000	2500	nA
	$V_{(\text{RBI})} > V_{(\text{RBI})\text{MIN}}$, $V_{\text{REG25}} < V_{\text{IT-}}$, $T_A = 25^\circ\text{C}$		90	220	
$V_{(\text{RB})}$ RB data-retention input voltage ⁽¹⁾		1.7			V

(1) Specified by design. Not production tested.

SMBus TIMING CHARACTERISTICS

 $T_A = -40^\circ\text{C}$ to 85°C Typical Values at $T_A = 25^\circ\text{C}$ and $V_{\text{REG25}} = 2.5\text{ V}$ (Unless Otherwise Noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{(\text{SMB})}$ SMBus operating frequency	Slave mode, SMBC 50% duty cycle	10		100	kHz
$f_{(\text{MAS})}$ SMBus master clock frequency	Master mode, No clock low slave extend		51.2		kHz
$t_{(\text{BUF})}$ Bus free time between start and stop (see Figure 1)		4.7			μs
$t_{(\text{HD:STA})}$ Hold time after (repeated) start (see Figure 1)		4			μs
$t_{(\text{SU:STA})}$ Repeated start setup time (see Figure 1)		4.7			μs
$t_{(\text{SU:STO})}$ Stop setup time (see Figure 1)		4			μs
$t_{(\text{HD:DAT})}$ Data hold time (see Figure 1)	Receive mode	0			ns
	Transmit mode	300			
$t_{(\text{SU:DAT})}$ Data setup time (see Figure 1)		250			ns
$t_{(\text{TIMEOUT})}$ Error signal/detect (see Figure 1)	See ⁽¹⁾	25		35	μs
$t_{(\text{LOW})}$ Clock low period (see Figure 1)		4.7			μs
$t_{(\text{HIGH})}$ Clock high period (see Figure 1)	See ⁽²⁾	4		50	μs
$t_{(\text{LOW:SEXT})}$ Cumulative clock low slave extend time	See ⁽³⁾			25	ms
$t_{(\text{LOW:MEXT})}$ Cumulative clock low master extend time (see Figure 1)	See ⁽⁴⁾			10	ms
t_f Clock/data fall time	See ⁽⁵⁾			300	ns
t_r Clock/data rise time	See ⁽⁶⁾			1000	ns

 (1) The bq20z45-R1 times out when any clock low exceeds $t_{(\text{TIMEOUT})}$.

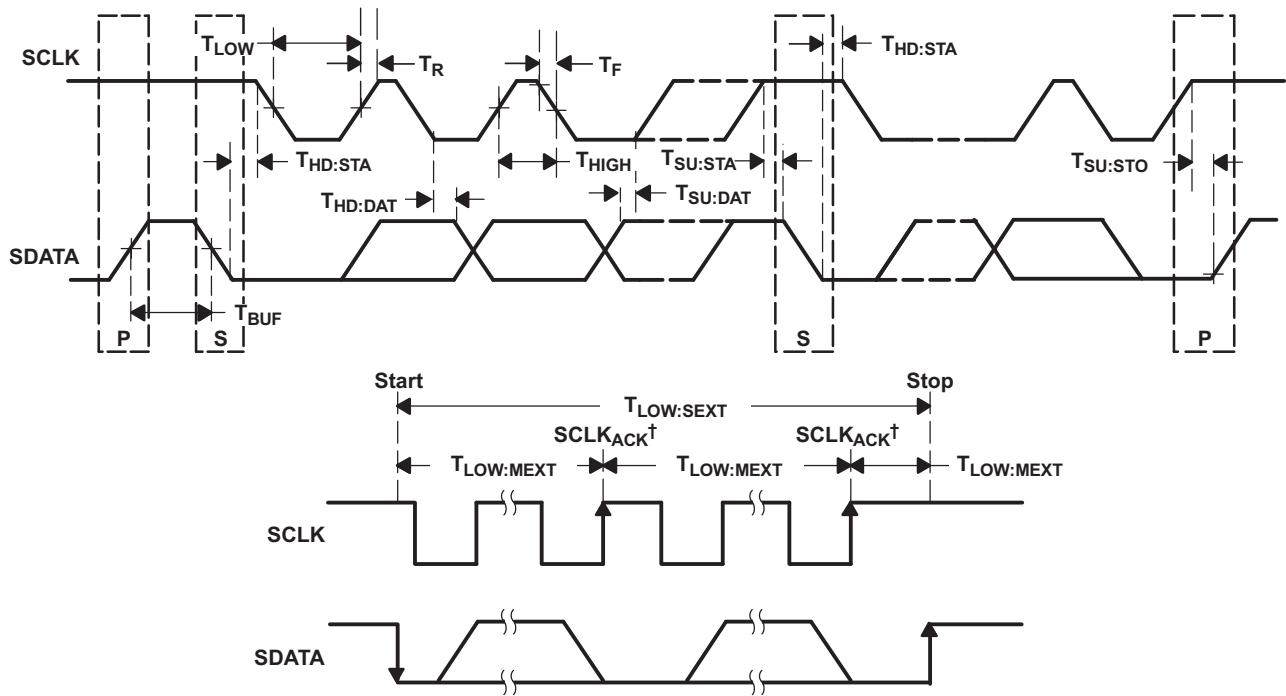
 (2) $t_{(\text{HIGH})}$, Max, is the minimum bus idle time. SMBC = SMBD = 1 for $t > 50\text{ ms}$ causes reset of any transaction involving bq20z45-R1 that is in progress. This specification is valid when the NC_SMB control bit remains in the default cleared state (CLK[0]=0).

 (3) $t_{(\text{LOW:SEXT})}$ is the cumulative time a slave device is allowed to extend the clock cycles in one message from initial start to the stop.

 (4) $t_{(\text{LOW:MEXT})}$ is the cumulative time a master device is allowed to extend the clock cycles in one message from initial start to the stop.

 (5) Rise time $t_r = V_{\text{ILMAX}} - 0.15$ to $(V_{\text{IHMIN}} + 0.15)$

 (6) Fall time $t_f = 0.9V_{\text{DD}}$ to $(V_{\text{ILMAX}} - 0.15)$



A. SCLKACK is the acknowledge-related clock pulse generated by the master.

Figure 1. SMBus Timing Diagram

FEATURE SET

Primary (1st Level) Safety Features

The bq20z45-R1 supports a wide range of battery and system protection features that can easily be configured. The primary safety features include:

- Cell over/undervoltage protection
- Charge and discharge overcurrent
- Short Circuit
- Charge and discharge overtemperature with independent alarms and thresholds for each thermistor
- AFE Watchdog

Secondary (2nd Level) Safety Features

The secondary safety features of the bq20z45-R1 can be used to indicate more serious faults via the SAFE (pin 7). This pin can be used to blow an in-line fuse to permanently disable the battery pack from charging or discharging. The secondary safety protection features include:

- Safety overvoltage
- Safety undervoltage
- Safety overcurrent in charge and discharge
- Safety overtemperature in charge and discharge with independent alarms and thresholds for each thermistor
- Charge FET and 0 Volt Charge FET fault
- Discharge FET fault
- Cell imbalance detection (active and at rest)
- Open thermistor detection
- AFE communication fault

Charge Control Features

The bq20z45-R1 charge control features include:

- Supports JEITA temperature ranges. Reports charging voltage and charging current according to the active temperature range.
- Handles more complex charging profiles. Allows for splitting the standard temperature range into 2 sub-ranges and allows for varying the charging current according to the cell voltage.
- Reports the appropriate charging current needed for constant current charging and the appropriate charging voltage needed for constant voltage charging to a smart charger using SMBus broadcasts.
- Determines the chemical state of charge of each battery cell using Impedance Track™ and can reduce the charge difference of the battery cells in fully charged state of the battery pack gradually using cell balancing algorithm during charging. This prevents fully charged cells from overcharging and causing excessive degradation and also increases the usable pack energy by preventing premature charge termination
- Supports pre-charging/zero-volt charging
- Supports charge inhibit and charge suspend if battery pack temperature is out of temperature range
- Reports charging fault and also indicate charge status via charge and discharge alarms.

Gas Gauging

The bq20z45-R1 uses the Impedance Track™ Technology to measure and calculate the available charge in battery cells. The achievable accuracy is better than 1% error over the lifetime of the battery and there is no full charge discharge learning cycle required.

See *Theory and Implementation of Impedance Track Battery Fuel-Gauging Algorithm* application note ([SLUA364](#)) for further details.

Lifetime Data Logging Features

The bq20z45-R1 offers lifetime data logging, where important measurements are stored for warranty and analysis purposes. The data monitored include:

- Lifetime maximum temperature
- Lifetime minimum temperature
- Lifetime maximum battery cell voltage
- Lifetime minimum battery cell voltage
- Lifetime maximum battery pack voltage
- Lifetime minimum battery pack voltage
- Lifetime maximum charge current
- Lifetime maximum discharge current
- Lifetime maximum charge power
- Lifetime maximum discharge power
- Lifetime maximum average discharge current
- Lifetime maximum average discharge power
- Lifetime average temperature

Authentication

The bq20z45-R1 supports authentication by the host using SHA-1.

Power Modes

The bq20z45-R1 supports 3 different power modes to reduce power consumption:

- In Normal Mode, the bq20z45-R1 performs measurements, calculations, protection decisions and data updates in 1 second intervals. Between these intervals, the bq20z45-R1 is in a reduced power stage.
- In Sleep Mode, the bq20z45-R1 performs measurements, calculations, protection decisions and data update in adjustable time intervals. Between these intervals, the bq20z45-R1 is in a reduced power stage. The bq20z45-R1 has a wake function that enables exit from Sleep mode, when current flow or failure is detected.
- In Shutdown Mode the bq20z45-R1 is completely disabled.

CONFIGURATION

Oscillator Function

The bq20z45-R1 fully integrates the system oscillators. Therefore the bq20z45-R1 requires no external components for this feature.

System Present Operation

The bq20z45-R1 checks the $\overline{\text{PRES}}$ pin periodically (1s). If $\overline{\text{PRES}}$ input is pulled to ground by external system, the bq20z45-R1 detects this as system present.

BATTERY PARAMETER MEASUREMENTS

The bq20z45-R1 uses an integrating delta-sigma analog-to-digital converter (ADC) for current measurement, and a second delta-sigma ADC for individual cell and battery voltage, and temperature measurement.

Charge and Discharge Counting

The integrating delta-sigma ADC measures the charge/discharge flow of the battery by measuring the voltage drop across a small-value sense resistor between the SR1 and SR2 pins. The integrating ADC measures bipolar signals from -0.25 V to 0.25 V. The bq20z45-R1 detects charge activity when $V_{\text{SR}} = V_{(\text{SRP})} - V_{(\text{SRN})}$ is positive and discharge activity when $V_{\text{SR}} = V_{(\text{SRP})} - V_{(\text{SRN})}$ is negative. The bq20z45-R1 continuously integrates the signal over time, using an internal counter. The fundamental rate of the counter is 0.65 nVh.

Voltage

The bq20z45-R1 updates the individual series cell voltages at one second intervals. The internal ADC of the bq20z45-R1 measures the voltage, scales and calibrates it appropriately. This data is also used to calculate the impedance of the cell for the Impedance Track™ gas-gauging.

Current

The bq20z45-R1 uses the SRP and SRN inputs to measure and calculate the battery charge and discharge current using a 5 mΩ to 20 mΩ typ. sense resistor.

Auto Calibration

The bq20z45-R1 provides an auto-calibration feature to cancel the voltage offset error across SRN and SRP for maximum charge measurement accuracy. The bq20z45-R1 performs auto-calibration when the SMBus lines stay low continuously for a minimum of 5 s.

Temperature

The bq20z45-R1 has an internal temperature sensor and inputs for 2 external temperature sensor inputs TS1 and TS2 used in conjunction with two identical NTC thermistors (default are Semitec 103AT) to sense the battery environmental temperature. The bq20z45-R1 can be configured to use internal or up to 2 external temperature sensors.

COMMUNICATIONS

The bq20z45-R1 uses SMBus v1.1 with Master Mode and package error checking (PEC) options per the SBS specification.

SMBus On and Off State

The bq20z45-R1 detects an SMBus off state when SMBC and SMBD are logic-low for ≥ 2 seconds. Clearing this state requires either SMBC or SMBD to transition high. Within 1 ms, the communication bus is available.

SBS Commands

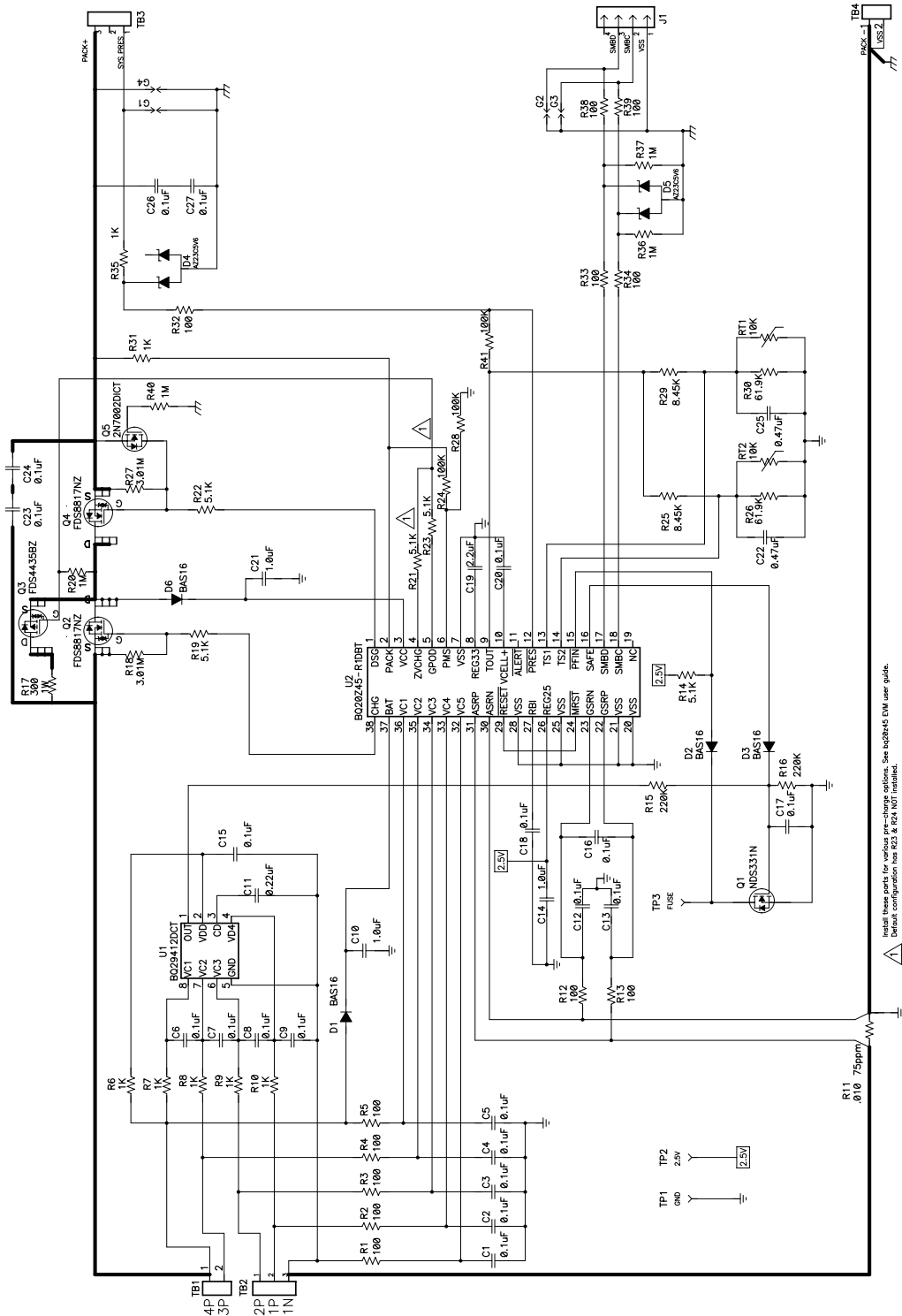
Table 2. SBS COMMANDS

SBS Cmd	Mode	Name	Format	Size in Bytes	Min Value	Max Value	Default Value	Unit
0x00	R/W	ManufacturerAccess	hex	2	0x0000	0xffff	—	—
0x01	R/W	RemainingCapacityAlarm	unsigned int	2	0	65535	300	mAh or 10mWh
0x02	R/W	RemainingTimeAlarm	unsigned int	2	0	65535	10	min
0x03	R/W	BatteryMode	hex	2	0x0000	0xe383	—	—
0x04	R/W	AtRate	signed int	2	-32768	32767	—	mA or 10mW
0x05	R	AtRateTimeToFull	unsigned int	2	0	65534	—	min
0x06	R	AtRateTimeToEmpty	unsigned int	2	0	65534	—	min
0x07	R	AtRateOK	unsigned int	2	0	65535	—	—
0x08	R	Temperature	unsigned int	2	0	65535	—	0.1°K
0x09	R	Voltage	unsigned int	2	0	65535	—	mV
0x0a	R	Current	signed int	2	-32768	32767	—	mA
0x0b	R	AverageCurrent	signed int	2	-32768	32767	—	mA
0x0c	R	MaxError	unsigned int	1	0	100	—	%
0x0d	R	RelativeStateOfCharge	unsigned int	1	0	100	—	%
0x0e	R	AbsoluteStateOfCharge	unsigned int	1	0	100+	—	%
0x0f	R/W	RemainingCapacity	unsigned int	2	0	65535	—	mAh or 10mWh
0x10	R	FullChargeCapacity	unsigned int	2	0	65535	—	mAh or 10mWh
0x11	R	RunTimeToEmpty	unsigned int	2	0	65534	—	min
0x12	R	AverageTimeToEmpty	unsigned int	2	0	65534	—	min
0x13	R	AverageTimeToFull	unsigned int	2	0	65534	—	min
0x14	R	ChargingCurrent	unsigned int	2	0	65534	—	mA
0x15	R	ChargingVoltage	unsigned int	2	0	65534	—	mV
0x16	R	BatteryStatus	unsigned int	2	0x0000	0xffff	—	—
0x17	R/W	CycleCount	unsigned int	2	0	65535	—	—
0x18	R/W	DesignCapacity	unsigned int	2	0	65535	4400	mAh or 10mWh
0x19	R/W	DesignVoltage	unsigned int	2	7000	16000	14400	mV
0x1a	R/W	SpecificationInfo	unsigned int	2	0x0000	0xffff	0x0031	—
0x1b	R/W	ManufactureDate	unsigned int	2	0	65535	01-Jan-1980	—
0x1c	R/W	SerialNumber	hex	2	0x0000	0xffff	0x0001	—
0x20	R/W	ManufacturerName	String	20+1	—	—	Texas Inst.	—
0x21	R/W	DeviceName	String	20+1	—	—	bq20z45-R1	—
0x22	R/W	DeviceChemistry	String	4+1	—	—	LION	—
0x23	R	ManufacturerData	String	14+1	—	—	—	—
0x2f	R/W	Authenticate	String	20+1	—	—	—	—
0x3c	R	CellVoltage4	unsigned int	2	0	65535	—	mV
0x3d	R	CellVoltage3	unsigned int	2	0	65535	—	mV
0x3e	R	CellVoltage2	unsigned int	2	0	65535	—	mV
0x3f	R	CellVoltage1	unsigned int	2	0	65535	—	mV

Table 3. EXTENDED SBS COMMANDS

SBS Cmd	Mode	Name	Format	Size in Bytes	Min Value	Max Value	Default Value	Unit
0x45	R	AFEDData	String	11+1	—	—	—	—
0x46	R/W	FETControl	hex	2	0x00	0xff	—	—
0x4f	R	StateOfHealth	hex	2	0x0000	0xffff	—	%
0x51	R	SafetyStatus	hex	2	0x0000	0xffff	—	—
0x53	R	PFStatus	hex	2	0x0000	0xffff	—	—
0x54	R	OperationStatus	hex	2	0x0000	0xffff	—	—
0x55	R	ChargingStatus	hex	2	0x0000	0xffff	—	—
0x57	R	ResetData	hex	2	0x0000	0xffff	—	—
0x58	R	WDRResetData	unsigned int	2	0	65535	—	—
0x5a	R	PackVoltage	unsigned int	2	0	65535	—	mV
0x5d	R	AverageVoltage	unsigned int	2	0	65535	—	mV
0x5e	R	TS1Temperature	integer	2	–400	1200	—	0.1°C
0x5f	R	TS2Temperature	integer	2	–400	1200	—	0.1°C
0x60	R/W	UnSealKey	hex	4	0x00000000	0xffffffff	—	—
0x61	R/W	FullAccessKey	hex	4	0x00000000	0xffffffff	—	—
0x62	R/W	PFKey	hex	4	0x00000000	0xffffffff	—	—
0x63	R/W	AuthenKey3	hex	4	0x00000000	0xffffffff	—	—
0x64	R/W	AuthenKey2	hex	4	0x00000000	0xffffffff	—	—
0x65	R/W	AuthenKey1	hex	4	0x00000000	0xffffffff	—	—
0x66	R/W	AuthenKey0	hex	4	0x00000000	0xffffffff	—	—
0x69	R	SafetyStatus2	hex	2	0x0000	0x000f	—	—
0x6b	R	PFStatus2	hex	2	0x0000	0x000f	—	—
0x6c	R/W	ManufBlock1	String	20	—	—	—	—
0x6d	R/W	ManufBlock2	String	20	—	—	—	—
0x6e	R/W	ManufBlock3	String	20	—	—	—	—
0x6f	R/W	ManufBlock4	String	20	—	—	—	—
0x70	R/W	ManufacturerInfo	String	31+1	—	—	—	—
0x71	R/W	SenseResistor	unsigned int	2	0	65535	—	μΩ
0x72	R	TempRange	hex	2	0x0000	0xffff	—	—
0x73	R	LifetimeData	String	32+1	—	—	—	—
0x77	R/W	DataFlashSubClassID	hex	2	0x0000	0xffff	—	—
0x78	R/W	DataFlashSubClassPage1	hex	32	—	—	—	—
0x79	R/W	DataFlashSubClassPage2	hex	32	—	—	—	—
0x7a	R/W	DataFlashSubClassPage3	hex	32	—	—	—	—
0x7b	R/W	DataFlashSubClassPage4	hex	32	—	—	—	—
0x7c	R/W	DataFlashSubClassPage5	hex	32	—	—	—	—
0x7d	R/W	DataFlashSubClassPage6	hex	32	—	—	—	—
0x7e	R/W	DataFlashSubClassPage7	hex	32	—	—	—	—
0x7f	R/W	DataFlashSubClassPage8	hex	32	—	—	—	—

APPLICATION SCHEMATIC



Install these parts for various pre-charge options. See bq20z45-EVM user guide. Default configuration has R23 & R24 NOT installed.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
BQ20Z45DBT-R1	NRND	TSSOP	DBT	38	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	20Z45	
BQ20Z45DBTR-R1	NRND	TSSOP	DBT	38	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	20Z45	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ20Z45DBTR-R1	TSSOP	DBT	38	2000	330.0	16.4	6.9	10.2	1.8	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



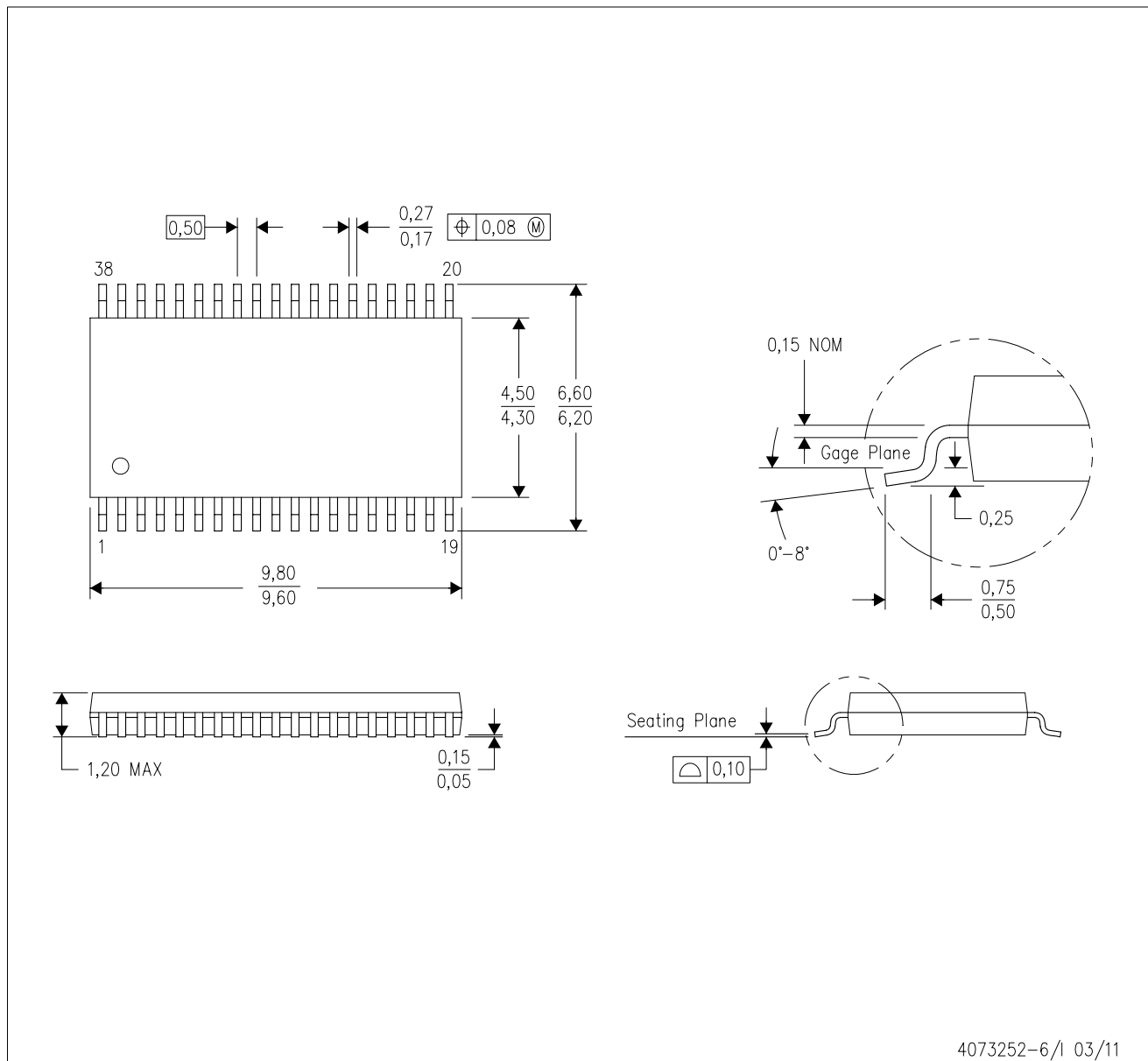
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ20Z45DBTR-R1	TSSOP	DBT	38	2000	350.0	350.0	43.0

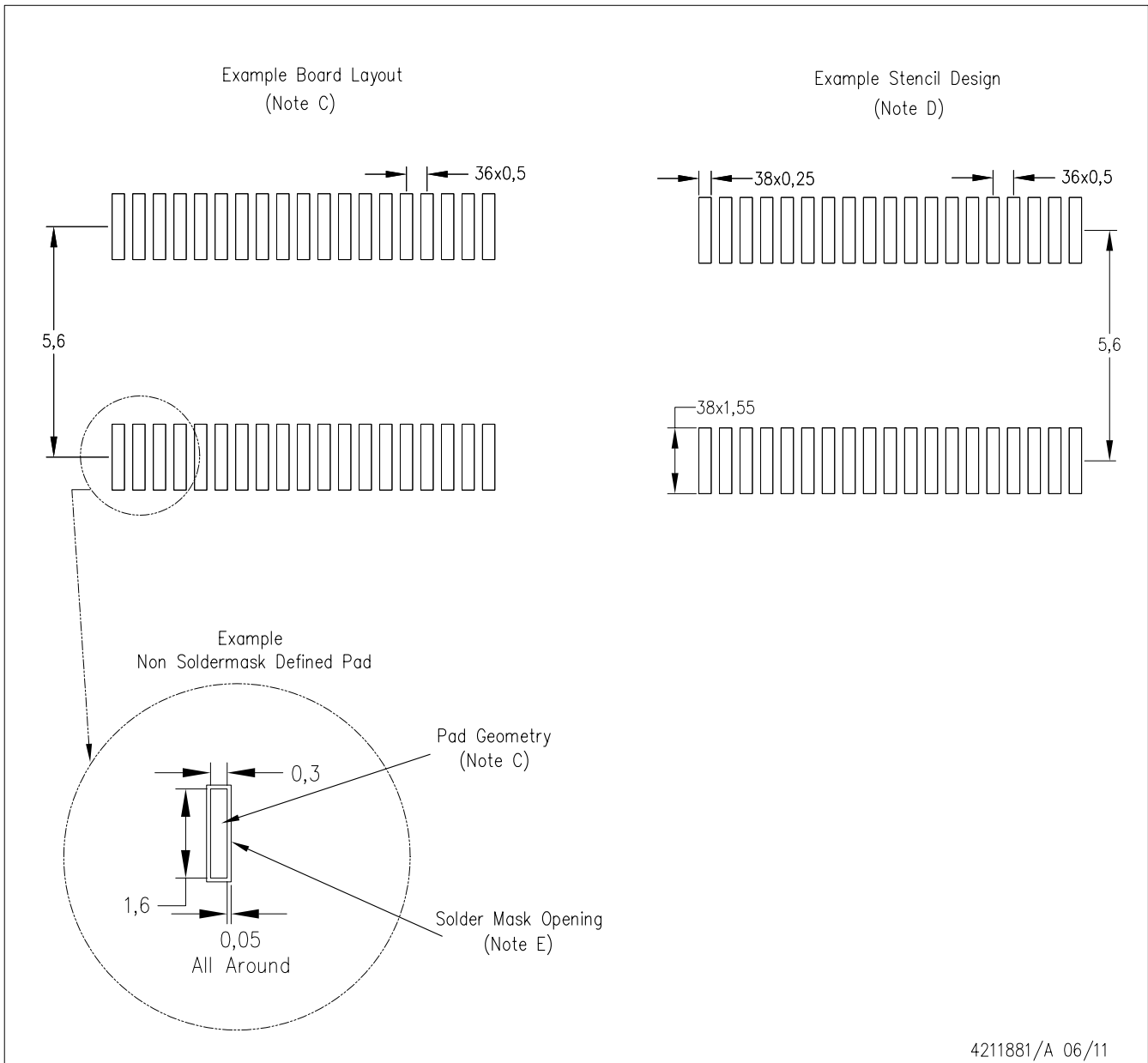
MECHANICAL DATA

DBT (R-PDSO-G38)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion.
 - Falls within JEDEC MO-153.



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2019, Texas Instruments Incorporated

Looking for pricing, stock, or lifecycle information?

Click below to explore more details on WIN SOURCE:

 [View BQ20Z45DBTR-R1](#) on WIN SOURCE

 [Texas Instruments](#) Information

Optimize Your Supply Chain with WIN SOURCE Solutions

-  Global Sourcing Solution
-  Obsolete Management
-  Cost Control Management
-  Shortage Management
-  Alternative Solution
-  Excess Inventory Management